Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/713,808	HOON ET AL.	
Examiner	Art Unit	
Sean E. Aeder, Ph.D.	1642	

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH		
	DATE	EXMR
STN (MEDLINE, BIOSIS, EMBASE, SCISEARCH, DISSABS; attached), MEDLINE, WEST (PGPB, USPT, USOC, EPAB, JPAB, DWPI; attached)	1/15/2007	SEA
PALM (inventor search)	1/15/2007	SEA
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